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Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

| | |
|--------------------------------|---|
| Product Status | Obsolete |
| Number of LABs/CLBs | - |
| Number of Logic Elements/Cells | 520 |
| Total RAM Bits | - |
| Number of I/O | 52 |
| Number of Gates | 20000 |
| Voltage - Supply | 1.425V ~ 1.575V |
| Mounting Type | Surface Mount |
| Operating Temperature | -20°C ~ 85°C (TJ) |
| Package / Case | 81-WFBGA, CSBGA |
| Supplier Device Package | 81-UCSP (4x4) |
| Purchase URL | https://www.e-xfl.com/product-detail/microsemi/agln020v5-ucg81 |

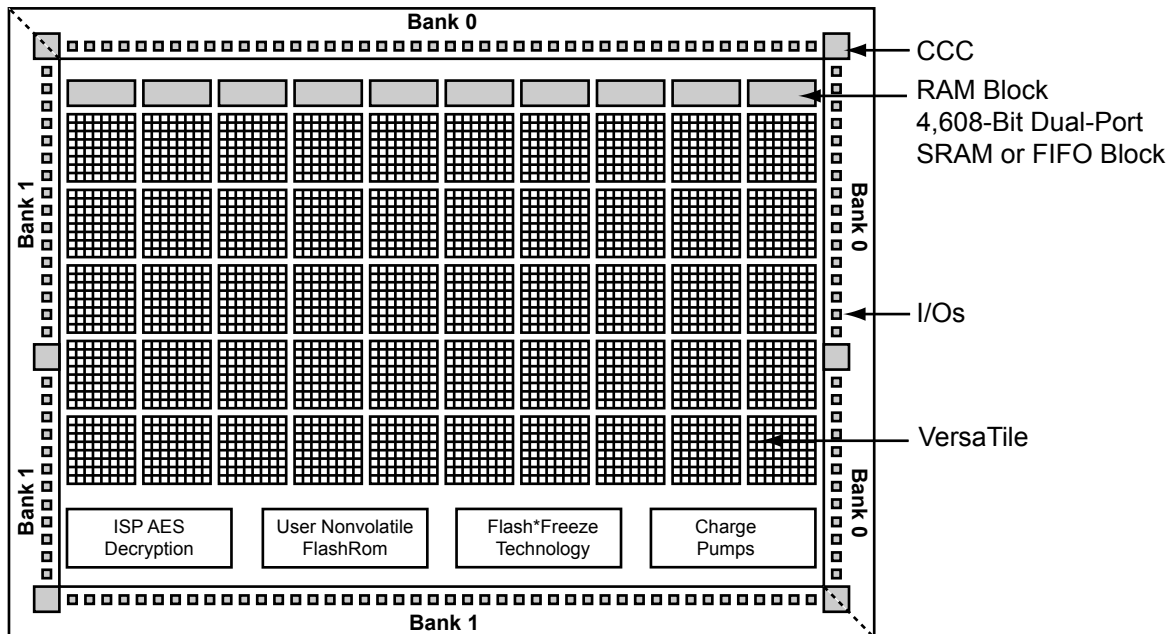


Figure 1-3 • IGLOO Device Architecture Overview with Two I/O Banks (AGLN060, AGLN125)

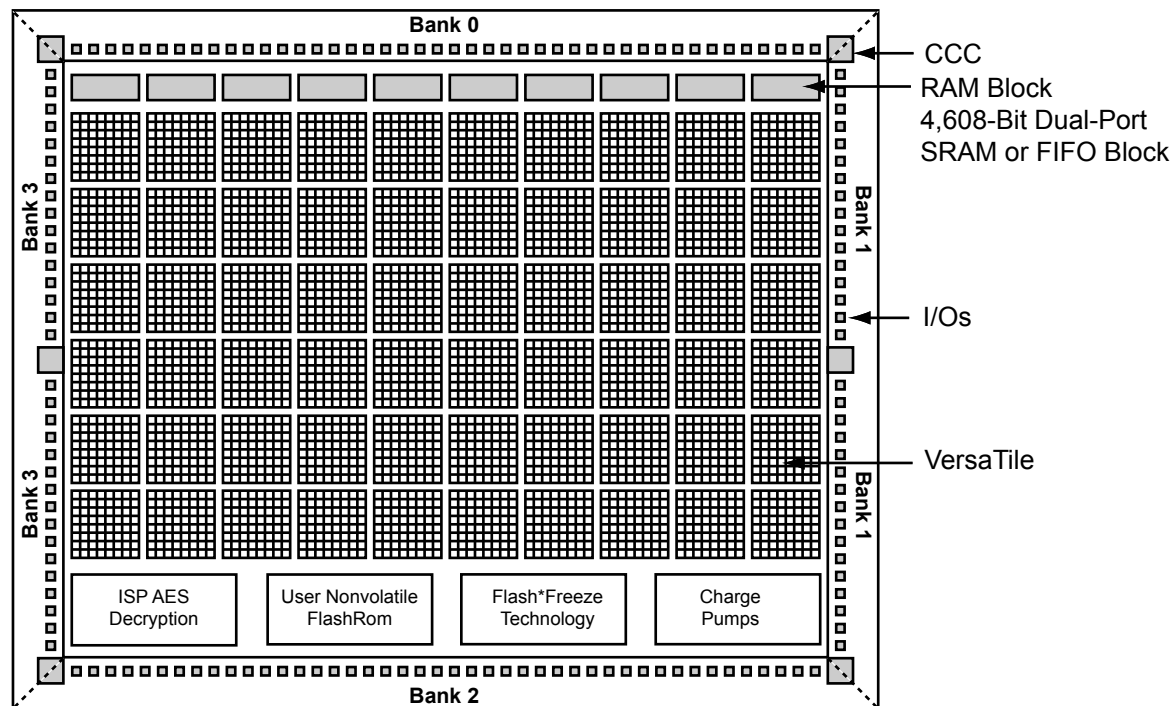


Figure 1-4 • IGLOO Device Architecture Overview with Four I/O Banks (AGLN250)

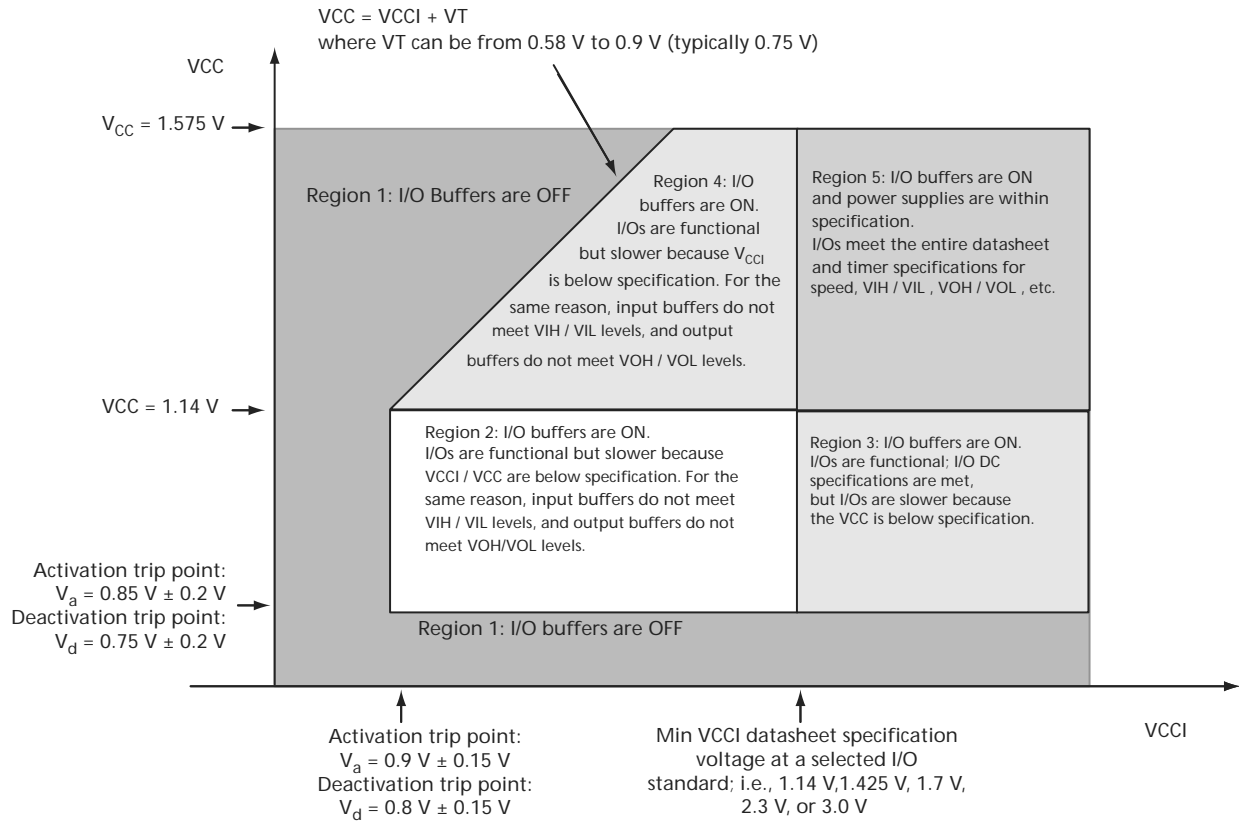


Figure 2-2 • V2 Devices – I/O State as a Function of V_{CCI} and V_{CC} Voltage Levels

Power Consumption of Various Internal Resources

Table 2-15 • Different Components Contributing to Dynamic Power Consumption in IGLOO nano Devices For IGLOO nano V2 or V5 Devices, 1.5 V Core Supply Voltage

| Parameter | Definition | Device Specific Dynamic Power ($\mu\text{W}/\text{MHz}$) | | | | | |
|-----------|--|--|---------|---------|---------|---------|---------|
| | | AGLN250 | AGLN125 | AGLN060 | AGLN020 | AGLN015 | AGLN010 |
| PAC1 | Clock contribution of a Global Rib | 4.421 | 4.493 | 2.700 | 0 | 0 | 0 |
| PAC2 | Clock contribution of a Global Spine | 2.704 | 1.976 | 1.982 | 4.002 | 4.002 | 2.633 |
| PAC3 | Clock contribution of a VersaTile row | 1.496 | 1.504 | 1.511 | 1.346 | 1.346 | 1.340 |
| PAC4 | Clock contribution of a VersaTile used as a sequential module | 0.152 | 0.153 | 0.153 | 0.148 | 0.148 | 0.143 |
| PAC5 | First contribution of a VersaTile used as a sequential module | 0.057 | | | | | |
| PAC6 | Second contribution of a VersaTile used as a sequential module | 0.207 | | | | | |
| PAC7 | Contribution of a VersaTile used as a combinatorial module | 0.17 | | | | | |
| PAC8 | Average contribution of a routing net | 0.7 | | | | | |
| PAC9 | Contribution of an I/O input pin (standard-dependent) | See Table 2-13 on page 2-9. | | | | | |
| PAC10 | Contribution of an I/O output pin (standard-dependent) | See Table 2-14. | | | | | |
| PAC11 | Average contribution of a RAM block during a read operation | 25.00 | | | N/A | | |
| PAC12 | Average contribution of a RAM block during a write operation | 30.00 | | | N/A | | |
| PAC13 | Dynamic contribution for PLL | 2.70 | | | N/A | | |

Table 2-16 • Different Components Contributing to the Static Power Consumption in IGLOO nano Devices For IGLOO nano V2 or V5 Devices, 1.5 V Core Supply Voltage

| Parameter | Definition | Device -Specific Static Power (mW) | | | | | |
|-------------------|--|------------------------------------|---------|---------|---------|---------|---------|
| | | AGLN250 | AGLN125 | AGLN060 | AGLN020 | AGLN015 | AGLN010 |
| PDC1 | Array static power in Active mode | See Table 2-12 on page 2-8 | | | | | |
| PDC2 | Array static power in Static (Idle) mode | See Table 2-12 on page 2-8 | | | | | |
| PDC3 | Array static power in Flash*Freeze mode | See Table 2-9 on page 2-7 | | | | | |
| PDC4 ¹ | Static PLL contribution | 1.84 | | | N/A | | |
| PDC5 | Bank quiescent power (VCCI-dependent) ² | See Table 2-12 on page 2-8 | | | | | |

Notes:

1. Minimum contribution of the PLL when running at lowest frequency.
2. For a different output load, drive strength, or slew rate, Microsemi recommends using the Microsemi power spreadsheet calculator or the SmartPower tool in Libero SoC.

Guidelines

Toggle Rate Definition

A toggle rate defines the frequency of a net or logic element relative to a clock. It is a percentage. If the toggle rate of a net is 100%, this means that this net switches at half the clock frequency. Below are some examples:

- The average toggle rate of a shift register is 100% because all flip-flop outputs toggle at half of the clock frequency.
- The average toggle rate of an 8-bit counter is 25%:
 - Bit 0 (LSB) = 100%
 - Bit 1 = 50%
 - Bit 2 = 25%
 - ...
 - Bit 7 (MSB) = 0.78125%
 - Average toggle rate = $(100\% + 50\% + 25\% + 12.5\% + \dots + 0.78125\%) / 8$

Enable Rate Definition

Output enable rate is the average percentage of time during which tristate outputs are enabled. When nontristate output buffers are used, the enable rate should be 100%.

Table 2-19 • Toggle Rate Guidelines Recommended for Power Calculation

| Component | Definition | Guideline |
|------------|----------------------------------|-----------|
| α_1 | Toggle rate of VersaTile outputs | 10% |
| α_2 | I/O buffer toggle rate | 10% |

Table 2-20 • Enable Rate Guidelines Recommended for Power Calculation

| Component | Definition | Guideline |
|-----------|--------------------------------------|-----------|
| β_1 | I/O output buffer enable rate | 100% |
| β_2 | RAM enable rate for read operations | 12.5% |
| β_3 | RAM enable rate for write operations | 12.5% |

I/O Register Specifications

Fully Registered I/O Buffers with Asynchronous Preset

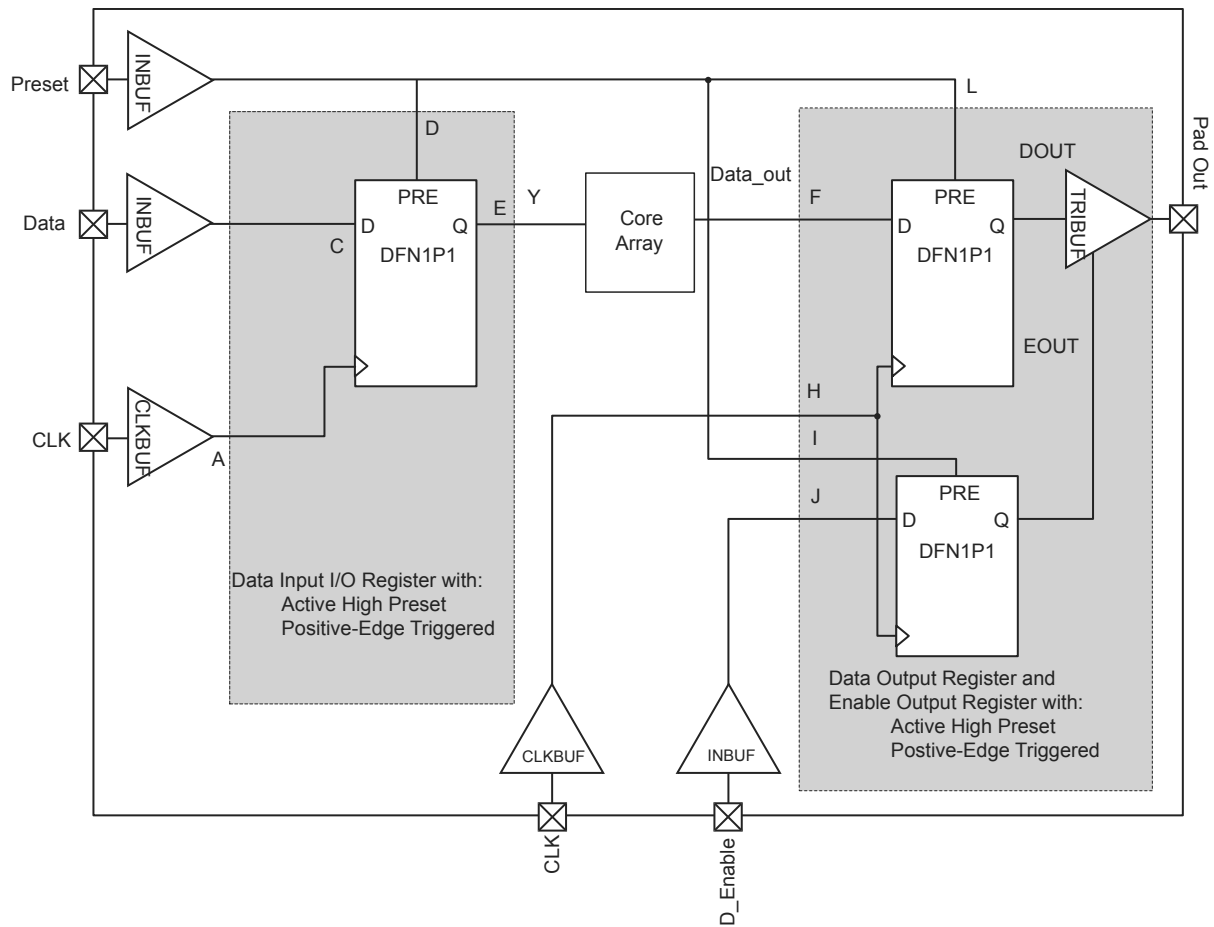


Figure 2-12 • Timing Model of Registered I/O Buffers with Asynchronous Preset

1.2 V DC Core Voltage

Table 2-73 • Input Data Register Propagation Delays
Commercial-Case Conditions: $T_J = 70^{\circ}\text{C}$, Worst-Case $V_{CC} = 1.14\text{ V}$

| Parameter | Description | Std. | Units |
|--------------|---|------|-------|
| t_{CLKQ} | Clock-to-Q of the Input Data Register | 0.68 | ns |
| t_{SUD} | Data Setup Time for the Input Data Register | 0.97 | ns |
| t_{HD} | Data Hold Time for the Input Data Register | 0.00 | ns |
| t_{CLR2Q} | Asynchronous Clear-to-Q of the Input Data Register | 1.19 | ns |
| t_{PRE2Q} | Asynchronous Preset-to-Q of the Input Data Register | 1.19 | ns |
| t_{REMCLR} | Asynchronous Clear Removal Time for the Input Data Register | 0.00 | ns |
| t_{RECCLR} | Asynchronous Clear Recovery Time for the Input Data Register | 0.24 | ns |
| t_{REMPRE} | Asynchronous Preset Removal Time for the Input Data Register | 0.00 | ns |
| t_{RECPRE} | Asynchronous Preset Recovery Time for the Input Data Register | 0.24 | ns |
| t_{WCLR} | Asynchronous Clear Minimum Pulse Width for the Input Data Register | 0.19 | ns |
| t_{WPRE} | Asynchronous Preset Minimum Pulse Width for the Input Data Register | 0.19 | ns |
| t_{CKMPWH} | Clock Minimum Pulse Width HIGH for the Input Data Register | 0.31 | ns |
| t_{CKMPWL} | Clock Minimum Pulse Width LOW for the Input Data Register | 0.28 | ns |

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-7 for derating values.

Table 2-90 • AGLN020 Global Resource
Commercial-Case Conditions: $T_J = 70^\circ\text{C}$, $V_{CC} = 1.425\text{ V}$

| Parameter | Description | Std. | | Units |
|---------------|---|-------------------|-------------------|-------|
| | | Min. ¹ | Max. ² | |
| t_{RCKL} | Input Low Delay for Global Clock | 1.21 | 1.55 | ns |
| t_{RCKH} | Input High Delay for Global Clock | 1.23 | 1.65 | ns |
| $t_{RCKMPWH}$ | Minimum Pulse Width High for Global Clock | 1.40 | | ns |
| $t_{RCKMPWL}$ | Minimum Pulse Width Low for Global Clock | 1.65 | | ns |
| t_{RCKSW} | Maximum Skew for Global Clock | | 0.42 | ns |

Notes:

1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
3. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-91 • AGLN060 Global Resource
Commercial-Case Conditions: $T_J = 70^\circ\text{C}$, $V_{CC} = 1.425\text{ V}$

| Parameter | Description | Std. | | Units |
|---------------|---|-------------------|-------------------|-------|
| | | Min. ¹ | Max. ² | |
| t_{RCKL} | Input Low Delay for Global Clock | 1.32 | 1.62 | ns |
| t_{RCKH} | Input High Delay for Global Clock | 1.34 | 1.71 | ns |
| $t_{RCKMPWH}$ | Minimum Pulse Width HIGH for Global Clock | 1.40 | | ns |
| $t_{RCKMPWL}$ | Minimum Pulse Width LOW for Global Clock | 1.65 | | ns |
| t_{RCKSW} | Maximum Skew for Global Clock | | 0.38 | ns |

Notes:

1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
3. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

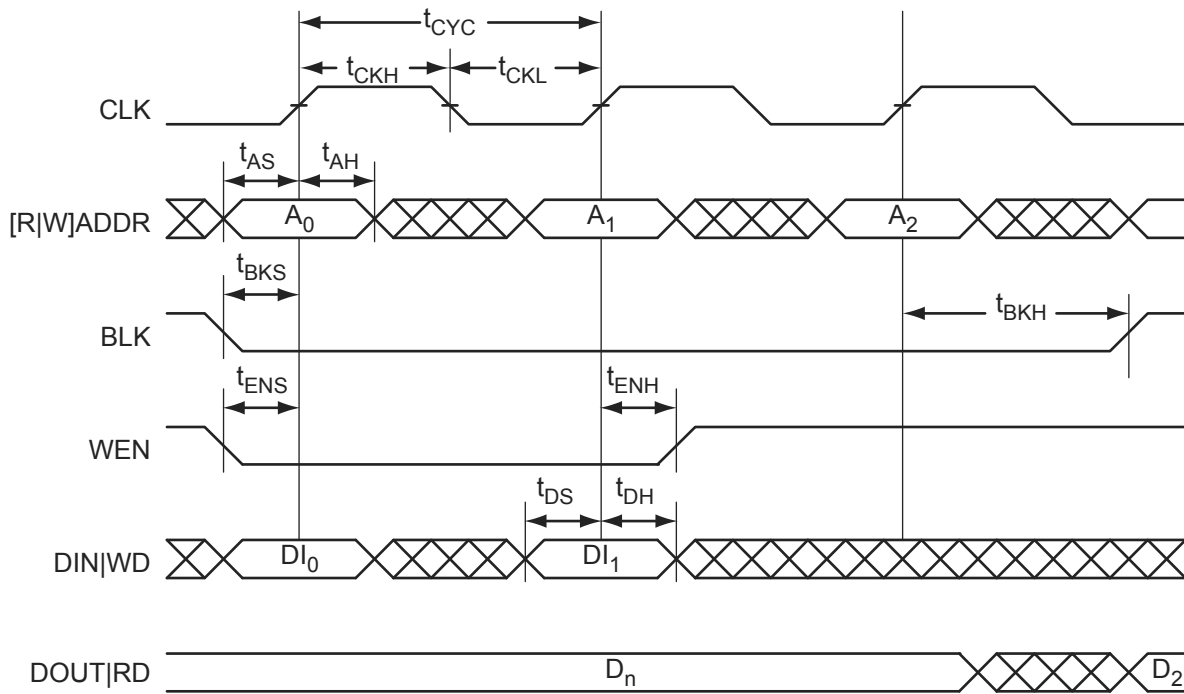


Figure 2-30 • RAM Write, Output Retained (WMODE = 0). Applicable to Both RAM4K9 and RAM512x18.

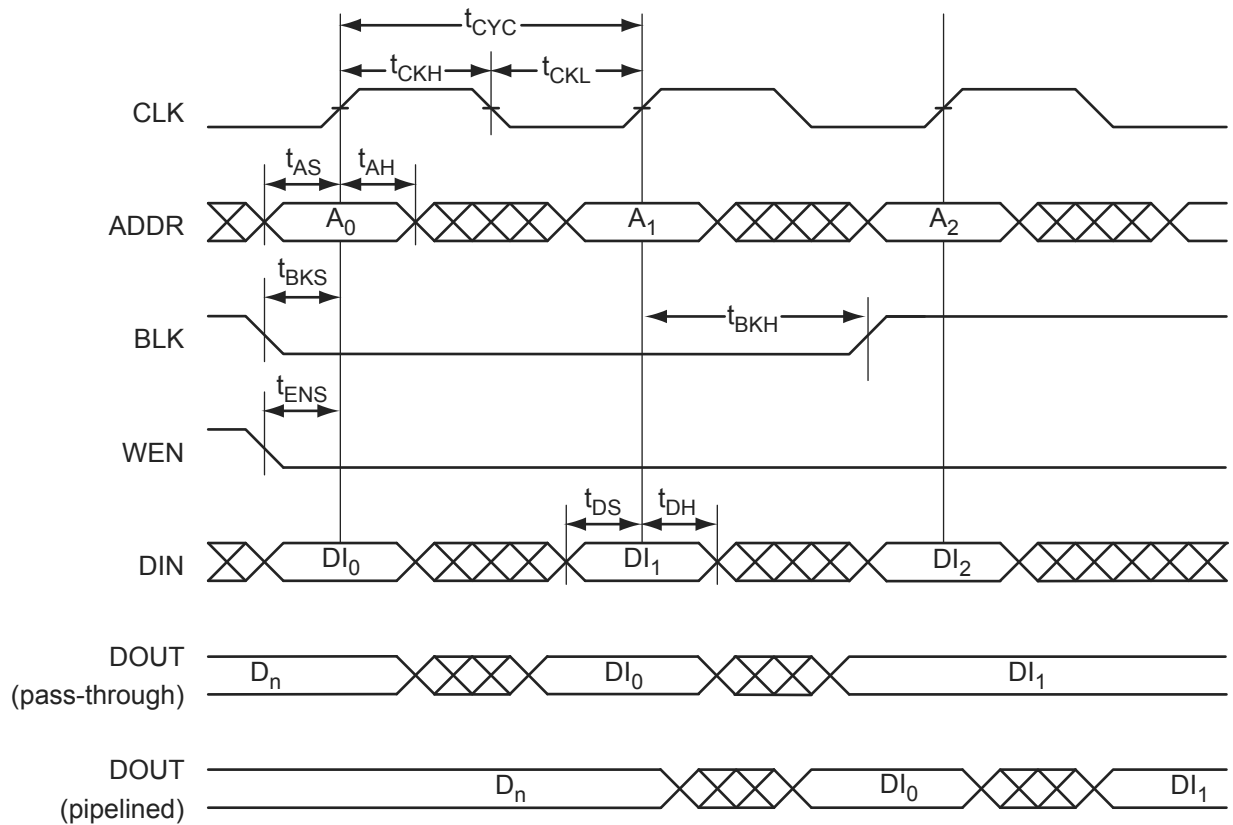


Figure 2-31 • RAM Write, Output as Write Data (WMODE = 1). Applicable to RAM4K9 Only.

Table 2-105 • RAM512X18

Commercial-Case Conditions: $T_J = 70^\circ\text{C}$, Worst-Case $V_{CC} = 1.14\text{ V}$

| Parameter | Description | Std. | Units |
|----------------|---|-------|-------|
| t_{AS} | Address setup time | 1.28 | ns |
| t_{AH} | Address hold time | 0.25 | ns |
| t_{ENS} | REN, WEN setup time | 1.13 | ns |
| t_{ENH} | REN, WEN hold time | 0.13 | ns |
| t_{DS} | Input data (WD) setup time | 1.10 | ns |
| t_{DH} | Input data (WD) hold time | 0.55 | ns |
| t_{CKQ1} | Clock High to new data valid on RD (output retained) | 6.56 | ns |
| t_{CKQ2} | Clock High to new data valid on RD (pipelined) | 2.67 | ns |
| t_{C2CRWH}^1 | Address collision clk-to-clk delay for reliable read access after write on same address; applicable to opening edge | 0.87 | ns |
| t_{C2CWRH}^1 | Address collision clk-to-clk delay for reliable write access after read on same address; applicable to opening edge | 1.04 | ns |
| t_{RSTBQ} | RESET LOW to data out LOW on RD (flow through) | 3.21 | ns |
| | RESET LOW to data out LOW on RD (pipelined) | 3.21 | ns |
| $t_{REMRSTB}$ | RESET removal | 0.93 | ns |
| $t_{RECRSTB}$ | RESET recovery | 4.94 | ns |
| $t_{MPWRSTB}$ | RESET minimum pulse width | 1.18 | ns |
| t_{CYC} | Clock cycle time | 10.90 | ns |
| F_{MAX} | Maximum frequency | 92 | MHz |

Notes:

1. For more information, refer to the application note AC374: Simultaneous Read-Write Operations in Dual-Port SRAM for Flash-Based FPGAs and SoC FPGAs App Note.
2. For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-7 for derating values.

FIFO

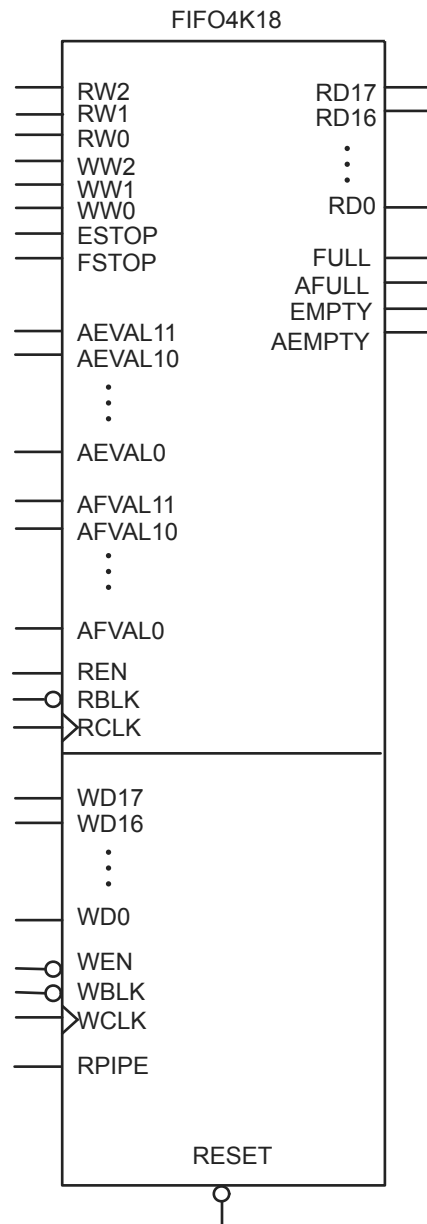


Figure 2-33 • FIFO Model

Timing Waveforms

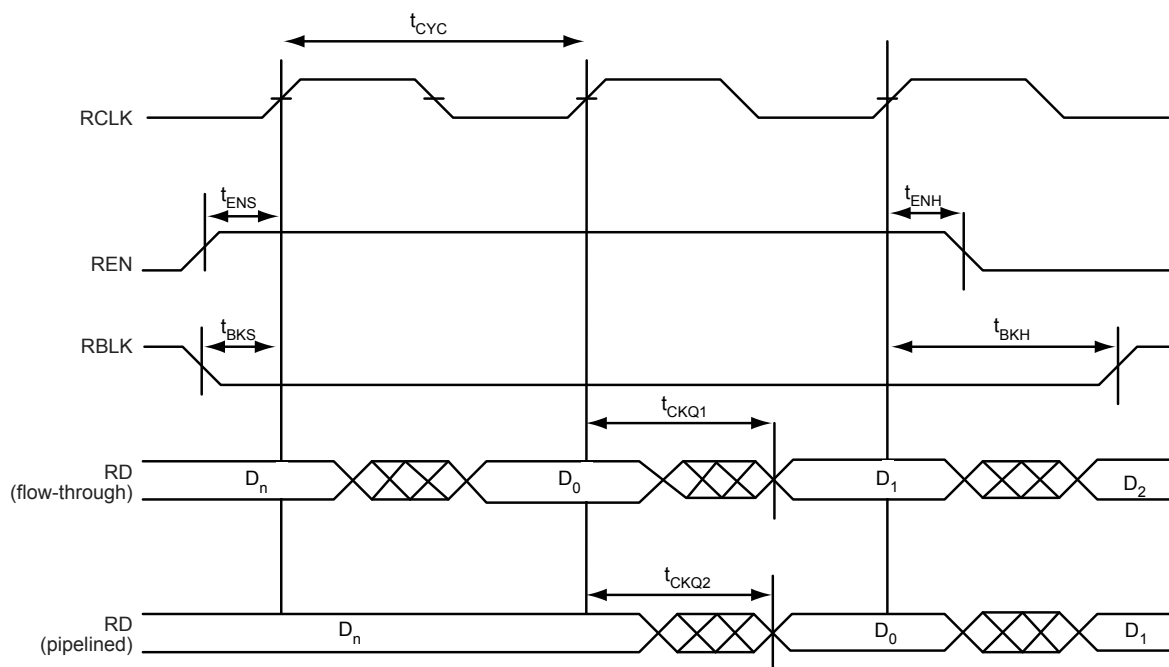


Figure 2-34 • FIFO Read

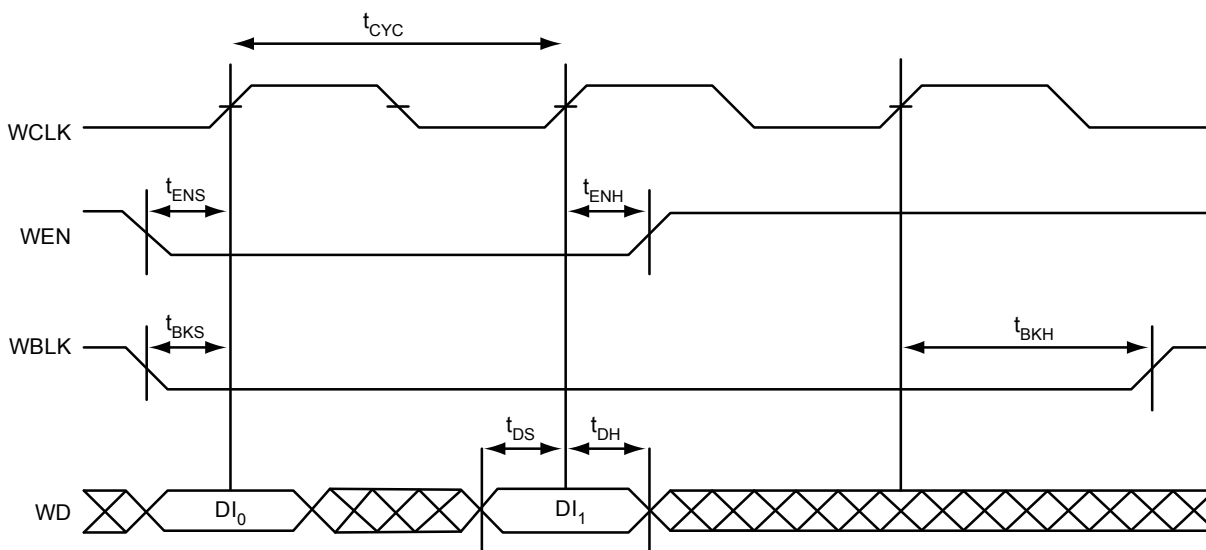


Figure 2-35 • FIFO Write

JTAG 1532 Characteristics

JTAG timing delays do not include JTAG I/Os. To obtain complete JTAG timing, add I/O buffer delays to the corresponding standard selected; refer to the I/O timing characteristics in the "User I/O Characteristics" section on page 2-15 for more details.

Timing Characteristics

1.5 V DC Core Voltage

Table 2-110 • JTAG 1532

Commercial-Case Conditions: $T_J = 70^\circ\text{C}$, Worst-Case VCC = 1.425 V

| Parameter | Description | Std. | Units |
|----------------------|-----------------------------|-------|-------|
| t_{DISU} | Test Data Input Setup Time | 1.00 | ns |
| t_{DIHD} | Test Data Input Hold Time | 2.00 | ns |
| t_{TMSSU} | Test Mode Select Setup Time | 1.00 | ns |
| t_{TMDHD} | Test Mode Select Hold Time | 2.00 | ns |
| t_{TCK2Q} | Clock to Q (data out) | 8.00 | ns |
| t_{RSTB2Q} | Reset to Q (data out) | 25.00 | ns |
| F_{TCKMAX} | TCK Maximum Frequency | 15 | MHz |
| t_{TRSTREM} | ResetB Removal Time | 0.58 | ns |
| t_{TRSTREC} | ResetB Recovery Time | 0.00 | ns |
| t_{TRSTMPW} | ResetB Minimum Pulse | TBD | ns |

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

1.2 V DC Core Voltage

Table 2-111 • JTAG 1532

Commercial-Case Conditions: $T_J = 70^\circ\text{C}$, Worst-Case VCC = 1.14 V

| Parameter | Description | Std. | Units |
|----------------------|-----------------------------|-------|-------|
| t_{DISU} | Test Data Input Setup Time | 1.50 | ns |
| t_{DIHD} | Test Data Input Hold Time | 3.00 | ns |
| t_{TMSSU} | Test Mode Select Setup Time | 1.50 | ns |
| t_{TMDHD} | Test Mode Select Hold Time | 3.00 | ns |
| t_{TCK2Q} | Clock to Q (data out) | 11.00 | ns |
| t_{RSTB2Q} | Reset to Q (data out) | 30.00 | ns |
| F_{TCKMAX} | TCK Maximum Frequency | 9.00 | MHz |
| t_{TRSTREM} | ResetB Removal Time | 1.18 | ns |
| t_{TRSTREC} | ResetB Recovery Time | 0.00 | ns |
| t_{TRSTMPW} | ResetB Minimum Pulse | TBD | ns |

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

should be treated as a sensitive asynchronous signal. When defining pin placement and board layout, simultaneously switching outputs (SSOs) and their effects on sensitive asynchronous pins must be considered.

Unused FF or I/O pins are tristated with weak pull-up. This default configuration applies to both Flash*Freeze mode and normal operation mode. No user intervention is required.

Table 3-1 shows the Flash*Freeze pin location on the available packages for IGLOO nano devices. The Flash*Freeze pin location is independent of device (except for a PQ208 package), allowing migration to larger or smaller IGLOO nano devices while maintaining the same pin location on the board. Refer to the "Flash*Freeze Technology and Low Power Modes" chapter of the *IGLOO nano FPGA Fabric User's Guide* for more information on I/O states during Flash*Freeze mode.

Table 3-1 • Flash*Freeze Pin Locations for IGLOO nano Devices

| Package | Flash*Freeze Pin |
|-----------|------------------|
| CS81/UC81 | H2 |
| QN48 | 14 |
| QN68 | 18 |
| VQ100 | 27 |
| UC36 | E2 |

JTAG Pins

Low power flash devices have a separate bank for the dedicated JTAG pins. The JTAG pins can be run at any voltage from 1.5 V to 3.3 V (nominal). VCC must also be powered for the JTAG state machine to operate, even if the device is in bypass mode; VJTAG alone is insufficient. Both VJTAG and VCC to the part must be supplied to allow JTAG signals to transition the device. Isolating the JTAG power supply in a separate I/O bank gives greater flexibility in supply selection and simplifies power supply and PCB design. If the JTAG interface is neither used nor planned for use, the VJTAG pin together with the TRST pin could be tied to GND.

TCK Test Clock

Test clock input for JTAG boundary scan, ISP, and UJTAG. The TCK pin does not have an internal pull-up/-down resistor. If JTAG is not used, Microsemi recommends tying off TCK to GND through a resistor placed close to the FPGA pin. This prevents JTAG operation in case TMS enters an undesired state.

Note that to operate at all VJTAG voltages, 500 Ω to 1 k Ω will satisfy the requirements. Refer to Table 3-2 for more information.

Table 3-2 • Recommended Tie-Off Values for the TCK and TRST Pins

| VJTAG | Tie-Off Resistance ^{1,2} |
|----------------|-----------------------------------|
| VJTAG at 3.3 V | 200 Ω to 1 k Ω |
| VJTAG at 2.5 V | 200 Ω to 1 k Ω |
| VJTAG at 1.8 V | 500 Ω to 1 k Ω |
| VJTAG at 1.5 V | 500 Ω to 1 k Ω |

Notes:

1. The TCK pin can be pulled-up or pulled-down.
2. The TRST pin is pulled-down.
3. Equivalent parallel resistance if more than one device is on the JTAG chain

Related Documents

User Guides

IGLOO nano FPGA Fabric User's Guide

Packaging Documents

The following documents provide packaging information and device selection for low power flash devices.

Product Catalog

FPGA and SoC Product Catalog

Lists devices currently recommended for new designs and the packages available for each member of the family. Use this document or the datasheet tables to determine the best package for your design, and which package drawing to use.

Package Mechanical Drawings

This document contains the package mechanical drawings for all packages currently or previously supplied by Microsemi. Use the bookmarks to navigate to the package mechanical drawings.

Additional packaging materials are on the Microsemi SoC Products Group website:

<http://www.microsemi.com/soc/products/solutions/package/docs.aspx>.

| UC81 | |
|------------|-------------------|
| Pin Number | AGLN030Z Function |
| A1 | IO00RSB0 |
| A2 | IO02RSB0 |
| A3 | IO06RSB0 |
| A4 | IO11RSB0 |
| A5 | IO16RSB0 |
| A6 | IO19RSB0 |
| A7 | IO22RSB0 |
| A8 | IO24RSB0 |
| A9 | IO26RSB0 |
| B1 | IO81RSB1 |
| B2 | IO04RSB0 |
| B3 | IO10RSB0 |
| B4 | IO13RSB0 |
| B5 | IO15RSB0 |
| B6 | IO20RSB0 |
| B7 | IO21RSB0 |
| B8 | IO28RSB0 |
| B9 | IO25RSB0 |
| C1 | IO79RSB1 |
| C2 | IO80RSB1 |
| C3 | IO08RSB0 |
| C4 | IO12RSB0 |
| C5 | IO17RSB0 |
| C6 | IO14RSB0 |
| C7 | IO18RSB0 |
| C8 | IO29RSB0 |
| C9 | IO27RSB0 |
| D1 | IO74RSB1 |
| D2 | IO76RSB1 |
| D3 | IO77RSB1 |
| D4 | VCC |
| D5 | VCCIB0 |
| D6 | GND |
| D7 | IO23RSB0 |
| D8 | IO31RSB0 |

| UC81 | |
|------------|-------------------|
| Pin Number | AGLN030Z Function |
| D9 | IO30RSB0 |
| E1 | GEB0/IO71RSB1 |
| E2 | GEA0/IO72RSB1 |
| E3 | GEC0/IO73RSB1 |
| E4 | VCCIB1 |
| E5 | VCC |
| E6 | VCCIB0 |
| E7 | GDC0/IO32RSB0 |
| E8 | GDA0/IO33RSB0 |
| E9 | GDB0/IO34RSB0 |
| F1 | IO68RSB1 |
| F2 | IO67RSB1 |
| F3 | IO64RSB1 |
| F4 | GND |
| F5 | VCCIB1 |
| F6 | IO47RSB1 |
| F7 | IO36RSB0 |
| F8 | IO38RSB0 |
| F9 | IO40RSB0 |
| G1 | IO65RSB1 |
| G2 | IO66RSB1 |
| G3 | IO57RSB1 |
| G4 | IO53RSB1 |
| G5 | IO49RSB1 |
| G6 | IO45RSB1 |
| G7 | IO46RSB1 |
| G8 | VJTAG |
| G9 | TRST |
| H1 | IO62RSB1 |
| H2 | FF/IO60RSB1 |
| H3 | IO58RSB1 |
| H4 | IO54RSB1 |
| H5 | IO48RSB1 |
| H6 | IO43RSB1 |
| H7 | IO42RSB1 |

| UC81 | |
|------------|-------------------|
| Pin Number | AGLN030Z Function |
| H8 | TDI |
| H9 | TDO |
| J1 | IO63RSB1 |
| J2 | IO61RSB1 |
| J3 | IO59RSB1 |
| J4 | IO56RSB1 |
| J5 | IO52RSB1 |
| J6 | IO44RSB1 |
| J7 | TCK |
| J8 | TMS |
| J9 | VPUMP |

| CS81 | |
|------------|-------------------|
| Pin Number | AGLN060Z Function |
| A1 | GAA0/IO02RSB0 |
| A2 | GAA1/IO03RSB0 |
| A3 | GAC0/IO06RSB0 |
| A4 | IO09RSB0 |
| A5 | IO13RSB0 |
| A6 | IO18RSB0 |
| A7 | GBB0/IO21RSB0 |
| A8 | GBA1/IO24RSB0 |
| A9 | GBA2/IO25RSB0 |
| B1 | GAA2/IO95RSB1 |
| B2 | GAB0/IO04RSB0 |
| B3 | GAC1/IO07RSB0 |
| B4 | IO08RSB0 |
| B5 | IO15RSB0 |
| B6 | GBC0/IO19RSB0 |
| B7 | GBB1/IO22RSB0 |
| B8 | IO26RSB0 |
| B9 | GBB2/IO27RSB0 |
| C1 | GAB2/IO93RSB1 |
| C2 | IO94RSB1 |
| C3 | GND |
| C4 | IO10RSB0 |
| C5 | IO17RSB0 |
| C6 | GND |
| C7 | GBA0/IO23RSB0 |
| C8 | GBC2/IO29RSB0 |
| C9 | IO31RSB0 |
| D1 | GAC2/IO91RSB1 |
| D2 | IO92RSB1 |
| D3 | GFA2/IO80RSB1 |
| D4 | VCC |
| D5 | VCCIB0 |
| D6 | GND |
| D7 | GCC2/IO43RSB0 |

| CS81 | |
|-----------------|-------------------|
| Pin Number | AGLN060Z Function |
| D8 | GCC1/IO35RSB0 |
| D9 | GCC0/IO36RSB0 |
| E1 | GFB0/IO83RSB1 |
| E2 | GFB1/IO84RSB1 |
| E3 | GFA1/IO81RSB1 |
| E4 | VCCIB1 |
| E5 | VCC |
| E6 | VCCIB0 |
| E7 | GCA1/IO39RSB0 |
| E8 | GCA0/IO40RSB0 |
| E9 | GCB2/IO42RSB0 |
| F1 ¹ | VCCPLF |
| F2 ¹ | VCOMPLF |
| F3 | GND |
| F4 | GND |
| F5 | VCCIB1 |
| F6 | GND |
| F7 | GDA1/IO49RSB0 |
| F8 | GDC1/IO45RSB0 |
| F9 | GDC0/IO46RSB0 |
| G1 | GEA0/IO69RSB1 |
| G2 | GEC1/IO74RSB1 |
| G3 | GEB1/IO72RSB1 |
| G4 | IO63RSB1 |
| G5 | IO60RSB1 |
| G6 | IO54RSB1 |
| G7 | GDB2/IO52RSB1 |
| G8 | VJTAG |
| G9 | TRST |
| H1 | GEA1/IO70RSB1 |
| H2 | FF/GEB2/IO67RSB1 |
| H3 | IO65RSB1 |
| H4 | IO62RSB1 |
| H5 | IO59RSB1 |

| CS81 | |
|-----------------|-------------------|
| Pin Number | AGLN060Z Function |
| H6 | IO56RSB1 |
| H7 ² | GDA2/IO51RSB1 |
| H8 | TDI |
| H9 | TDO |
| J1 | GEA2/IO68RSB1 |
| J2 | GEC2/IO66RSB1 |
| J3 | IO64RSB1 |
| J4 | IO61RSB1 |
| J5 | IO58RSB1 |
| J6 | IO55RSB1 |
| J7 | TCK |
| J8 | TMS |
| J9 | VPUMP |

Notes:

1. Pin numbers F1 and F2 must be connected to ground because a PLL is not supported for AGLN060Z-CS81.
2. The bus hold attribute (hold previous I/O state in Flash*Freeze mode) is not supported for pin H7 in AGLN060Z-CS81.

| VQ100 | |
|------------|-------------------|
| Pin Number | AGLN250Z Function |
| 1 | GND |
| 2 | GAA2/IO67RSB3 |
| 3 | IO66RSB3 |
| 4 | GAB2/IO65RSB3 |
| 5 | IO64RSB3 |
| 6 | GAC2/IO63RSB3 |
| 7 | IO62RSB3 |
| 8 | IO61RSB3 |
| 9 | GND |
| 10 | GFB1/IO60RSB3 |
| 11 | GFB0/IO59RSB3 |
| 12 | VCOMPLF |
| 13 | GFA0/IO57RSB3 |
| 14 | VCCPLF |
| 15 | GFA1/IO58RSB3 |
| 16 | GFA2/IO56RSB3 |
| 17 | VCC |
| 18 | VCCIB3 |
| 19 | GFC2/IO55RSB3 |
| 20 | GEC1/IO54RSB3 |
| 21 | GEC0/IO53RSB3 |
| 22 | GEA1/IO52RSB3 |
| 23 | GEA0/IO51RSB3 |
| 24 | VMV3 |
| 25 | GNDQ |
| 26 | GEA2/IO50RSB2 |
| 27 | FF/GEA2/IO49RSB2 |
| 28 | GEC2/IO48RSB2 |
| 29 | IO47RSB2 |
| 30 | IO46RSB2 |
| 31 | IO45RSB2 |
| 32 | IO44RSB2 |
| 33 | IO43RSB2 |
| 34 | IO42RSB2 |
| 35 | IO41RSB2 |
| 36 | IO40RSB2 |

| VQ100 | |
|------------|-------------------|
| Pin Number | AGLN250Z Function |
| 37 | VCC |
| 38 | GND |
| 39 | VCCIB2 |
| 40 | IO39RSB2 |
| 41 | IO38RSB2 |
| 42 | IO37RSB2 |
| 43 | GDC2/IO36RSB2 |
| 44 | GDB2/IO35RSB2 |
| 45 | GDA2/IO34RSB2 |
| 46 | GNDQ |
| 47 | TCK |
| 48 | TDI |
| 49 | TMS |
| 50 | VMV2 |
| 51 | GND |
| 52 | VPUMP |
| 53 | NC |
| 54 | TDO |
| 55 | TRST |
| 56 | VJTAG |
| 57 | GDA1/IO33RSB1 |
| 58 | GDC0/IO32RSB1 |
| 59 | GDC1/IO31RSB1 |
| 60 | IO30RSB1 |
| 61 | GCB2/IO29RSB1 |
| 62 | GCA1/IO27RSB1 |
| 63 | GCA0/IO28RSB1 |
| 64 | GCC0/IO26RSB1 |
| 65 | GCC1/IO25RSB1 |
| 66 | VCCIB1 |
| 67 | GND |
| 68 | VCC |
| 69 | IO24RSB1 |
| 70 | GBC2/IO23RSB1 |
| 71 | GGB2/IO22RSB1 |
| 72 | IO21RSB1 |

| VQ100 | |
|------------|-------------------|
| Pin Number | AGLN250Z Function |
| 73 | GBA2/IO20RSB1 |
| 74 | VMV1 |
| 75 | GNDQ |
| 76 | GBA1/IO19RSB0 |
| 77 | GBA0/IO18RSB0 |
| 78 | GGB1/IO17RSB0 |
| 79 | GGB0/IO16RSB0 |
| 80 | GBC1/IO15RSB0 |
| 81 | GBC0/IO14RSB0 |
| 82 | IO13RSB0 |
| 83 | IO12RSB0 |
| 84 | IO11RSB0 |
| 85 | IO10RSB0 |
| 86 | IO09RSB0 |
| 87 | VCCIB0 |
| 88 | GND |
| 89 | VCC |
| 90 | IO08RSB0 |
| 91 | IO07RSB0 |
| 92 | IO06RSB0 |
| 93 | GAC1/IO05RSB0 |
| 94 | GAC0/IO04RSB0 |
| 95 | GAB1/IO03RSB0 |
| 96 | GAB0/IO02RSB0 |
| 97 | GAA1/IO01RSB0 |
| 98 | GAA0/IO00RSB0 |
| 99 | GNDQ |
| 100 | VMV0 |

| Revision / Version | Changes | Page |
|---|--|----------------------|
| Revision 9 (Mar2010) Product Brief Advance v0.9 Packaging Advance v0.8 | All product tables and pin tables were updated to show clearly that AGLN030 is available only in the Z feature grade at this time. The nano-Z feature grade devices are designated with a Z at the end of the part number. | N/A |
| Revision 8 (Jan 2009) Product Brief Advance v0.8 | The "Reprogrammable Flash Technology" section was revised to add "250 MHz (1.5 V systems) and 160 MHz (1.2 V systems) System Performance". | I |
| | The note for AGLN030 in the "IGLOO nano Devices" table and "I/Os Per Package" table was revised to remove the statement regarding package compatibility with lower density nano devices. | II, II |
| | The "I/Os with Advanced I/O Standards" section was revised to add definitions for hot-swap and cold-sparing. | 1-8 |
| Packaging Advance v0.7 | The "UC81", "CS81", "QN48", and "QN68" pin tables for AGLN030 are new. | 4-5, 4-8, 4-17, 4-21 |
| | The "CS81" pin table for AGLN060 is new. | 4-9 |
| | The "CS81" and "VQ100" pin tables for AGLN060Z are new. | 4-10, 4-25 |
| | The "CS81" and "VQ100" pin tables for AGLN125Z are new. | 4-12, 4-27 |
| | The "CS81" and "VQ100" pin tables for AGLN250Z are new. | 4-14, 4-29 |
| Revision 7 (Apr 2009) Product Brief Advance v0.7 DC and Switching Characteristics Advance v0.3 | The –F speed grade is no longer offered for IGLOO nano devices and was removed from the datasheet. | N/A |
| Revision 6 (Mar 2009) Packaging Advance v0.6 | The "VQ100" pin table for AGLN030 is new. | 4-23 |
| Revision 5 (Feb 2009) Packaging Advance v0.5 | The "100-Pin QFN" section was removed. | N/A |
| Revision 4 (Feb 2009) Product Brief Advance v0.6 | The QN100 package was removed for all devices. | N/A |
| | "IGLOO nano Devices" table was updated to change the maximum user I/Os for AGLN030 from 81 to 77. | II |
| | The "Device Marking" section is new. | V |
| Revision 3 (Feb 2009) Product Brief Advance v0.5 | The following table note was removed from "IGLOO nano Devices" table: "Six chip (main) and three quadrant global networks are available for AGLN060 and above." | II |
| | The CS81 package was added for AGLN250 in the "IGLOO nano Products Available in the Z Feature Grade" table. | VI |
| Packaging Advance v0.4 | The "UC81" and "CS81" pin tables for AGLN020 are new. | 4-4, 4-7 |
| | The "CS81" pin table for AGLN250 is new. | 4-13 |

| Revision / Version | Changes | Page |
|--|--|------------|
| Revision 2 (Dec 2008) Product Brief Advance v0.4 Packaging Advance v0.3 | The second table note in "IGLOO nano Devices" table was revised to state, "AGLN060, AGLN125, and AGLN250 in the CS81 package do not support PLLs. AGLN030 and smaller devices do not support this feature." | II |
| | The I/Os per package for CS81 were revised to 60 for AGLN060, AGLN125, and AGLN250 in the "I/Os Per Package" table. | II |
| | The "UC36" pin table is new. | 4-2 |
| Revision 1 (Nov 2008) Product Brief Advance v0.3 | The "Advanced I/Os" section was updated to include wide power supply voltage support for 1.14 V to 1.575 V. | I |
| | The AGLN030 device was added to product tables and replaces AGL030 entries that were formerly in the tables. | VI |
| | The "I/Os Per Package" table was updated for the CS81 package to change the number of I/Os for AGLN060, AGLN125, and AGLN250 from 66 to 64. | II |
| | The "Wide Range I/O Support" section is new. | 1-8 |
| | The table notes and references were revised in Table 2-2 • Recommended Operating Conditions ¹ . VMV was included with VCCI and a table note was added stating, "VMV pins must be connected to the corresponding VCCI pins. See <i>Pin Descriptions</i> for further information." Please review carefully. | 2-2 |
| | VJTAG was added to the list in the table note for Table 2-9 • Quiescent Supply Current (IDD) Characteristics, IGLOO nano Flash*Freeze Mode*. Values were added for AGLN010, AGLN015, and AGLN030 for 1.5 V. | 2-7 |
| | VCCI was removed from the list in the table note for Table 2-10 • Quiescent Supply Current (IDD) Characteristics, IGLOO nano Sleep Mode*. | 2-8 |
| | Values for I _{CCA} current were updated for AGLN010, AGLN015, and AGLN030 in Table 2-12 • Quiescent Supply Current (IDD), No IGLOO nano Flash*Freeze Mode ¹ . | 2-8 |
| | Values for PAC1 and PAC2 were added to Table 2-15 • Different Components Contributing to Dynamic Power Consumption in IGLOO nano Devices and Table 2-17 • Different Components Contributing to Dynamic Power Consumption in IGLOO nano Devices. | 2-10, 2-11 |
| | Table notes regarding wide range support were added to Table 2-21 • Summary of Maximum and Minimum DC Input and Output Levels. | 2-19 |
| | 1.2 V LVCMOS wide range values were added to Table 2-22 • Summary of Maximum and Minimum DC Input Levels and Table 2-23 • Summary of AC Measuring Points. | 2-19, 2-20 |
| | The following table note was added to Table 2-25 • Summary of I/O Timing Characteristics—Software Default Settings and Table 2-26 • Summary of I/O Timing Characteristics—Software Default Settings: "All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range, as specified in the JESD8-B specification." | 2-21 |
| | 3.3 V LVCMOS Wide Range and 1.2 V Wide Range were added to Table 2-28 • I/O Output Buffer Maximum Resistances ¹ and Table 2-30 • I/O Short Currents IOSH/IOSL. | 2-23, 2-24 |